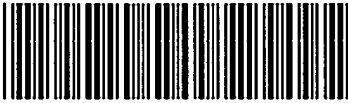


Search Notes

Application/Control No.

10/509,789

Examiner

Chris H. Chu

Applicant(s)/Patent under
Reexamination

CHANCLOU, PHILIPPE

Art Unit

2874

SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| applicants' cited references | 12/23/2005 | CC |
| text search | 12/23/2005 | CC |
| IEEE database | 12/27/2005 | CC |
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